

CLAIMS

1. An apparatus for performing the polymerase chain reaction in a plurality of liquid reaction mixtures; said apparatus including a plurality of vials containing such liquid reaction mixtures, said vials having an upper portion and a lower portion; said apparatus comprising:

an assembly for cycling said vials through a series of temperature excursions;

a cover for applying a seating force directly to said vials and for applying a constant temperature to the upper portion of said vials; and

a computing apparatus for controlling said temperature excursions of said assembly and said constant temperature of said cover.

2. The apparatus of claim 1 wherein said assembly comprises:

a sample block for receiving said vials;

a plurality of thermal electric devices;

a heat sink;

a clamping mechanism positioned so as to clamp said Peltier thermal electric devices between said sample block and said heatsink;

a heater positioned loosely around the perimeter of said sample block; and

a pin having a first end and a second end, said first end in close contact with said sample block and said second end in close contact with said heatsink so as to provide a thermal path between said sample block and said heatsink.

3. The apparatus of claim 2 wherein said sample block comprises:

a plurality of sample wells, for receiving sample vials, each well having a top and bottom;

an upper support plate connecting the tops of said sample wells.

4. The apparatus of claim 3 wherein said upper support plate and said sample wells are electroformed as a single piece.

5. The apparatus of claim 3 wherein said sample block is comprised of silver.
- C1 6. The apparatus of claim 3 wherein said sample wells are arranged in an 8 x 12 array.
7. The apparatus of claim 3 wherein sample block is rectangular.
- sub 8. The apparatus of claim 2 wherein said plurality of Peltier thermoelectric devices are matched to provide a temperature within 0.2 C for a given input current.
- A 9. The apparatus of claim 2 wherein said Peltier thermoelectric devices comprise:
a first ceramic layer having bonded copper traces;
a second ceramic layer having bonded copper traces, said second ceramic layer comprising a plurality of ceramic elements; and
a plurality of bismuth telluride pellets positioned between said first ceramic layer and said second ceramic layer and soldered to said bonded copper traces on said first and second ceramic layers.
- sub 10. The apparatus of claim 9 wherein the ceramic of said first and second layer is alumina.
11. The apparatus of claim 9 wherein the ceramic layers have a thickness of 0.508mm.
12. The apparatus of claim 9 wherein said bismuth telluride pellets are soldered using high temperature solder.
- sub 13. The apparatus of claim 9 wherein the resistivity of the devices is determined from the equation:

$$R = nr(h/A)$$

where R is the resistivity of the device, n is the number of pellets, r is the resistivity of the bismuth telluride being used, h is the height of the pellet and A is the cross sectional area of the bismuth telluride.

14. The apparatus of claim 1 wherein said heatsink comprises:
 a plate having a top side and a bottom side;
 a plurality of fins extending perpendicularly from said bottom side;
 a trench extending around the perimeter of said top side to impede heat loss from said perimeter;
 a fan placed in close proximity to said fins to control air flow through said fins;
 and
 a recess within said plate for receiving a temperature sensor.
15. The assembly of claim 1 wherein said clamping mechanism comprises:
 a spine and said spine having a plurality of openings in said spine for receiving fasteners;
 a plurality of fingers extending laterally from said spine.
16. The apparatus mechanism of claim 15 wherein said spine is rectangular in shape.
17. The apparatus mechanism of claim 15 wherein said fingers are rectangular in shape.
18. The apparatus of claim 15 wherein said fingers have a top and a bottom and are tapered so as to have less width at said top than at said bottom.
19. The apparatus of claim 15 wherein said fingers have a first end protruding laterally from said spine and a protrusion extending downward from said first end.

20. The apparatus of claim 15 wherein said fingers have a beveled front edge.

21. The apparatus of claim 15 wherein each of said openings are located in close proximity to a corresponding finger.

A 22. The apparatus of claim 2 wherein said heater comprises an electrically resistive path embedded in a frame shaped film carrier.

23. The apparatus of claim 22 wherein said electrically resistive path comprises a first set of sections located on opposite sides of said frame shaped carrier having a first power density and a second set of sections located on opposite sides of said frame shaped having a second power density.

A 24. The apparatus of claim 2 further comprising an associated memory device capable of storing data related to said assembly.

25. The apparatus of Claim 1 wherein said cover comprises:

a platen, vertically and horizontally displaceable in relationship to said vials, said platen including:

an array of openings corresponding to locations of said vials, said openings having a perimeter corresponding to a perimeter of said vials;

a skirt extending downward around the perimeter of said platen, said skirt having dimensions corresponding to the perimeter of a standard microtiter tray, said skirt constructed to engage said perimeter of said tray during vertical displacement of said platen, causing said openings in said platen to engage said perimeter of said vials, applying a seating force on said vials for maintaining a snug fit between walls of said sample vials and said assembly for receiving said sample vials;

means for forcibly lowering said platen to maintain said seating force; and

heating means positioned in close contact with said platen to maintain said platen at a constant temperature.

26. The apparatus of claim 1 wherein said assembly comprises of at least one device for changing the temperature of said apparatus further comprising a system for measuring the AC resistance of said thermal electric device.

27. The apparatus of claim 26 wherein at least one device has a first heating and cooling surface and a second heating and cooling surface, said system comprising:

- a first temperature sensor positioned so as to be in thermal communication with said first heating and cooling surface;
- a second temperature sensor positioned so as to be in thermal communication with said second heating and cooling surface;
- a bi-polar amplifier circuit for providing power to said ~~thermal electric~~ ^{thermoelectric} device;
- a circuit for sensing AC voltage across said ~~thermal electric~~ ^{thermoelectric} device and producing a DC voltage representing said AC voltage;
- a circuit for sensing AC current through said ~~thermal electric~~ ^{thermoelectric} device and producing a DC voltage representing said AC current;
- a microcontroller programmed to receive said signals from said first and second temperature sensors;
- said microcontroller further programmed to cause said bi-polar amplifier to provide power to said ~~thermal electric~~ ^{thermoelectric} device so that said first and second temperature sensor signals indicate equal temperatures;
- said microcontroller further programmed to cause an AC voltage to be superimposed on said bi-polar amplifier power;
- said microcontroller further programmed to receive said voltages produced by said circuit for sensing AC voltage and from said circuit for sensing AC current;

A ~~thermal electric~~ ^{thermoelectric} device further programmed to calculate the AC resistance of said thermal electric device from said voltages;

C ~~thermal electric~~ said microcontroller further programmed to compensate for ambient temperature error by performing a polynomial calculation; and

said microcontroller further programmed to store said compensated AC resistance measurement.

Sub A6 28. A method for measuring the AC resistance of a thermal electric device having a first heating and cooling surface and a second heating and cooling surface, said method comprising:

measuring the temperature of said first heating and cooling surface;
 measuring the temperature of said second heating and cooling surface;
 applying power to said Peltier thermal electric device to cause said first heating and cooling surface and said second heating and cooling surface to attain the same temperature;

applying an AC voltage across said thermal electric device;
 measuring said AC voltage across said thermal electric device;
 measuring AC current through said thermal electric device;
 calculating the AC resistance of said thermal electric device from said measured AC voltage and said measured AC current.

Sub C 29. The method of claim 28, further comprising:
 performing a calculation for compensating for ambient temperature error to calculate a compensation AC resistance measurement; and
 storing said compensated AC resistance measurement.

Sub A6 30. A method for achieving linear temperature transitions utilizing a thermal electric device having at least a first heating and cooling surface and a second heating and cooling surface and being operated in a manner causing said first surface to be higher in

said method comprising:

And

DATE	DESCRIPTION	AMOUNT	CHECK NO.	BANK	INITIALS
10/1/19	DEPOSIT	100.00		CHASE	ABC
10/5/19	PAYROLL	50.00	101	CHASE	ABC
10/10/19	RENT	25.00	102	CHASE	ABC
10/15/19	UTILITIES	15.00	103	CHASE	ABC
10/20/19	SALES	75.00	104	CHASE	ABC
10/25/19	DEPOSIT	100.00		CHASE	ABC
10/30/19	PAYROLL	50.00	105	CHASE	ABC
11/5/19	RENT	25.00	106	CHASE	ABC
11/10/19	UTILITIES	15.00	107	CHASE	ABC
11/15/19	SALES	75.00	108	CHASE	ABC
11/20/19	DEPOSIT	100.00		CHASE	ABC
11/25/19	PAYROLL	50.00	109	CHASE	ABC
11/30/19	RENT	25.00	110	CHASE	ABC
12/5/19	UTILITIES	15.00	111	CHASE	ABC
12/10/19	SALES	75.00	112	CHASE	ABC
12/15/19	DEPOSIT	100.00		CHASE	ABC
12/20/19	PAYROLL	50.00	113	CHASE	ABC
12/25/19	RENT	25.00	114	CHASE	ABC
12/30/19	UTILITIES	15.00	115	CHASE	ABC
1/5/20	SALES	75.00	116	CHASE	ABC
1/10/20	DEPOSIT	100.00		CHASE	ABC
1/15/20	PAYROLL	50.00	117	CHASE	ABC
1/20/20	RENT	25.00	118	CHASE	ABC
1/25/20	UTILITIES	15.00	119	CHASE	ABC
1/30/20	SALES	75.00	120	CHASE	ABC
2/5/20	DEPOSIT	100.00		CHASE	ABC
2/10/20	PAYROLL	50.00	121	CHASE	ABC
2/15/20	RENT	25.00	122	CHASE	ABC
2/20/20	UTILITIES	15.00	123	CHASE	ABC
2/25/20	SALES	75.00	124	CHASE	ABC
2/28/20	DEPOSIT	100.00		CHASE	ABC

✓ A
no period

sub
B'

33. An assembly for cycling vials of reaction mixtures through a series of temperature excursions comprising:
- a sample block for receiving vials of reaction mixtures;
 - a plurality of thermal electric devices;
 - a heat sink;
 - a clamping mechanism positioned so as to clamp said thermal electric devices between said sample block and said heatsink;
 - a heater positioned around the perimeter of said sample block; and
 - a pin having a first end and a second end, said first end in close contact with said sample block and said second end in close contact with said heatsink so as to provide a thermal path between said sample block and said heatsink;
 - a computing apparatus for controlling said temperature excursions of said assembly and said heater.
34. A sample block for holding sample vials comprising:
- a plurality of sample wells, for receiving sample vials, each well having a top and bottom;
 - an upper support plate connecting the tops of said sample wells; and
 - a bottom plate connecting the bottom of said sample wells
35. The sample block of claim 34 wherein said upper support plate and said sample wells are electroformed as a single piece.
36. The sample block of claim 34 wherein said sample block is comprised of silver.
37. The sample block of claim 34 wherein said sample wells are arranged in an 8 x 12 array.
38. The sample block of claim 34 wherein sample block is rectangular.

40. An apparatus for measuring the AC resistance of a ~~Peltier~~ ^{thermoelectric} thermal electric device having a first heating and cooling surface and a second heating and cooling surface, said system comprising:
- a first temperature sensor positioned so as to be in thermal communication with said first heating and cooling surface;
 - a second temperature sensor positioned so as to be in thermal communication with said second heating and cooling surface;
 - a bi-polar amplifier circuit for providing power to said thermal electric device;
 - a circuit for sensing AC voltage across said ~~thermal electric~~ ^{thermoelectric} device and producing a DC voltage representing said AC voltage;
 - a circuit for sensing AC current through said ~~thermal electric~~ ^{thermoelectric} device and producing a DC voltage representing said AC current;
 - a microcontroller programmed to receive said signals from said first and second temperature sensors;
 - said microcontroller further programmed to cause said bi-polar amplifier to provide power to said ~~thermal electric~~ ^{thermoelectric} device so that said first and second temperature sensor signals are equal;
 - said microcontroller further programmed to cause an AC voltage to be superimposed on said bi-polar amplifier power;
 - said microcontroller further programmed to receive said voltages produced by said circuit for sensing AC voltage and from said circuit for sensing AC current;

said microcontroller further programmed to compensate for ambient temperature error by performing a polynomial calculation; and

9806

	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	31	32	33	34	35	36	37	38	39	40	41	42	43	44	45	46	47	48	49	50	51	52	53	54	55	56	57	58	59	60	61	62	63	64	65	66	67	68	69	70	71	72	73	74	75	76	77	78	79	80	81	82	83	84	85	86	87	88	89	90	91	92	93	94	95	96	97	98	99	100																																																																																																																																																											
0	00000000	00000001	00000010	00000011	00000100	00000101	00000110	00000111	00001000	00001001	00001010	00001011	00001100	00001101	00001110	00001111	00010000	00010001	00010010	00010011	00010100	00010101	00010110	00010111	00011000	00011001	00011010	00011011	00011100	00011101	00011110	00011111	00100000	00100001	00100010	00100011	00100100	00100101	00100110	00100111	00101000	00101001	00101010	00101011	00101100	00101101	00101110	00101111	00110000	00110001	00110010	00110011	00110100	00110101	00110110	00110111	00111000	00111001	00111010	00111011	00111100	00111101	00111110	00111111	01000000	01000001	01000010	01000011	01000100	01000101	01000110	01000111	01001000	01001001	01001010	01001011	01001100	01001101	01001110	01001111	01010000	01010001	01010010	01010011	01010100	01010101	01010110	01010111	01011000	01011001	01011010	01011011	01011100	01011101	01011110	01011111	01100000	01100001	01100010	01100011	01100100	01100101	01100110	01100111	01101000	01101001	01101010	01101011	01101100	01101101	01101110	01101111	01110000	01110001	01110010	01110011	01110100	01110101	01110110	01110111	01111000	01111001	01111010	01111011	01111100	01111101	01111110	01111111	10000000	10000001	10000010	10000011	10000100	10000101	10000110	10000111	10001000	10001001	10001010	10001011	10001100	10001101	10001110	10001111	10010000	10010001	10010010	10010011	10010100	10010101	10010110	10010111	10011000	10011001	10011010	10011011	10011100	10011101	10011110	10011111	10100000	10100001	10100010	10100011	10100100	10100101	10100110	10100111	10101000	10101001	10101010	10101011	10101100	10101101	10101110	10101111	10110000	10110001	10110010	10110011	10110100	10110101	10110110	10110111	10111000	10111001	10111010	10111011	10111100	10111101	10111110	10111111	11000000	11000001	11000010	11000011	11000100	11000101	11000110	11000111	11001000	11001001	11001010	11001011	11001100	11001101	11001110	11001111	11010000	11010001	11010010	11010011	11010100	11010101	11010110	11010111	11011000	11011001	11011010	11011011	11011100	11011101	11011110	11011111	11100000	11100001	11100010	11100011	11100100	11100101	11100110	11100111	11101000	11101001	11101010	11101011	11101100	11101101	11101110	11101111	11110000	11110001	11110010	11110011	11110100	11110101	11110110	11110111	11111000	11111001	11111010	11111011	11111100	11111101	11111110	11111111